| PCN Number: | | 20140414001 | PCN Date: | | 4/14/2014 | | | | |
|---|--|--|---------------------|-------------------|-----------------------------------|-------|---------------------------------|--|--|
| Title: Design Revision (for Select TMP708/709 Devices) | | | | | | | | | |
| Customer Contact: | | PCN Manager Phor | | +1(214)480-6037 | | Dept: | Quality Services | | |
| Proposed 1 st Ship Da | | te: <mark>10/14/2014</mark> 7/14/2014 | | | Estimated Sample Availability: | | Date provided at sample request | | |
| Change Type: | | | | | | | | | |
| Design | | | | | | | | | |
| PCN Details | | | | | | | | | |
| Description of Change: | | | | | | | | | |
| The purpose of Revision B is to correct the 1 st Ship Date above. This PCN will expire on 7/14/2014 and the change may be implemented. We apologize for any confusion this may have caused. This notification is to inform of a design revision for select TMP708/709 devices. This design change does not affect the device's guaranteed datasheet specifications or electrical performance. The affected devices are listed in the "Product Affected" section. The table below describes changes that were made: | | | | | | | | | |
| Description of Cha | | nange | Ве | Benefit of Change | | | | | |
| Revision of die to eliminate startup issue | | sue. Im | Improve reliability | | | | | | |
| | | | | | | | | | |
| Reason for Change: | | | | | | | | | |
| Improve reliability | | | | | | | | | |
| Anticipated impact on Form, Fit, Function, Quality or Reliability (positive / negative): | | | | | | | | | |
| None | | | | | | | | | |



| Qual Device: TMP708AIDBV | | | | | | | | | |
|--------------------------------------|---------------------|--------------------------------|----------------------------|------|--|--|--|--|--|
| Package/Die Construction Details | | | | | | | | | |
| Assembly Site: | NFME | # Pins-Designator, Family: 5-I | | SOT | | | | | |
| Fab Process: | 50HPA07 | Die Revision: B | | • | | | | | |
| Qualification: 🗌 Plan 🛛 Test Results | | | | | | | | | |
| Reliability Test | | Conditions | Sample Size (PASS/FAIL) | | | | | | |
| Electrical Characteriz | ation, side by side | Per Datasheet Parameters | | Pass | | | | | |
| ESD HBM | | 1000V | | 3/0 | | | | | |
| ESD CDM | | 250V | | 3/0 | | | | | |
| Latch-up | | Per JESD78 | | 6/0 | | | | | |

For questions regarding this notice, e-mails can be sent to the regional contacts shown below or to your local Field Sales Representative.

| Location | E-Mail |
|--------------|--------------------------------|
| USA | PCNAmericasContact@list.ti.com |
| Europe | PCNEuropeContact@list.ti.com |
| Asia Pacific | PCNAsiaContact@list.ti.com |
| Japan | PCNJapanContact@list.ti.com |